

TCP2014

Thursday, 4 December 2014

session1: Ion Traps for HCI (2) (08:10 - 10:40)

-Conveners: Toshiyuki Azuma

time	[id] title	presenter
08:10	[135] The high precision mass spectrometer-SMILETRAP meets an EBIT in Shanghai	Dr YAO, Ke
08:35	[136] Spectroscopic studies of highly charged ions at the Tokyo electron beam ion trap facility	Dr NAKAMURA, Nobuyuki
09:00	[137] Coulomb-crystalized highly charged ions	Dr VERSOLATO, Oscar
09:25	[138] Using GPU parallelization to perform realistic simulations of the LPCTrap experiments : from a trapped ion cloud to a time-of-flight measurement.	Mr FABIAN, Xavier
09:45	[139] Status of the ReA Electron Beam Ion Trap Charge Breeder at NSCL	Dr BAUMANN, Thomas
10:05	[140] Dynamical effects in the X-ray transition strengths of astrophysically relevant Fe16+ ions	Dr ORESHKINA, Natalia
10:25	[141] High-resolution intensity ratio measurements in EUV spectral wavelength for ions of astrophysical interest	Dr SAFDAR, Ali